Application/Control No. Applicant(s)/Patent Under Reexamination 10/051,176 DUCELLIER ET AL. Notice of References Cited Examiner Art Unit Daniel E Valada 91303 Page 1 of 1 2874 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2002/0067887 06-2002 385/37 Tomlinson et al. US-US-С US-D US-Ε US-F G US-USн 1 US-US-J Κ US-US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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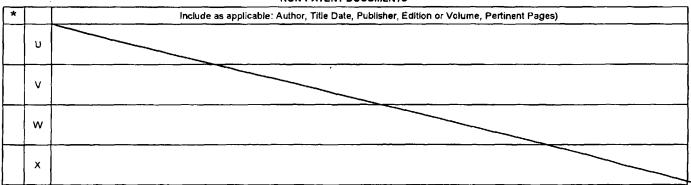
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